


<b>Search Notes</b>  	<b>Application/Control No.</b>  10750175	<b>Applicant(s)/Patent Under Reexamination</b>  DANG ET AL.
	<b>Examiner</b>  Trimmings, John P	<b>Art Unit</b>  2117

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
326/41,38, 714/724,726,734,731,30. Text strategy attaced (see EAST printout).	4/9/2007	jpt
Dble Patent Search: Negative (see printout).	4/9/2007	jpt
NPL Search: scan chains and fpga or pld and test mode.	4/9/2007	jpt
326/41,38,40, 714/724,727,725,729,742,726,734,731,30. Text strategy attached (see EAST printout).	1/14/2008	jpt
Dble Patent Search: Negative (see printout).	1/17/2008	jpt
NPL Search: Negative.	1/17/2008	jpt
Updated above searches (see EAST printout).	5/6/2008	jpt

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
All	See claim text search in attached EAST printout.	5/7/2008	jpt